

<b>Notice of References Cited</b>	Application/Control No. 10/772,651	Applicant(s)/Patent Under Reexamination SHIN ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,133,637	10-2000	Hikita et al.	257/777
	B	US-6,569,709	05-2003	Derderian, James M.	438/109
	C	US-6,486,554	11-2002	Johnson, Eric Arthur	257/738
	D	US-2003/0111720	06-2003	Tan et al.	257/686
	E	US-2004/0051168	03-2004	Arai et al.	257/678
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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